

#### Final datasheet

## EconoDUAL™3 module with CoolSiC™ Trench MOSFET and PressFIT / NTC

#### **Features**

- · Electrical features
  - V<sub>DSS</sub> = 1200 V
  - $I_{DN} = 500 \text{ A} / I_{DRM} = 1000 \text{ A}$
  - Integrated temperature sensor
  - Suitable Infineon gate drivers can be found under https://www.infineon.com/gdfinder
- Mechanical features
  - Standard housing
  - PressFIT contact technology
  - Isolated base plate
  - High power density
  - Direct-cooled base plate

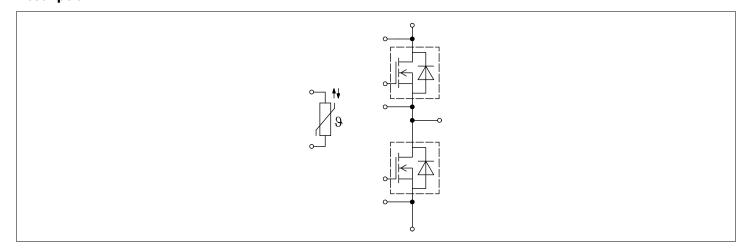
#### **Potential applications**

- Construction, commercial, and agriculture vehicles
- Wind turbines
- Motor drives
- UPS systems
- · Solar applications

#### **Product validation**

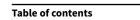
• Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

#### **Description**





## **EconoDUAL™3 module**





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## **EconoDUAL™3 module**

1 Package



# 1 Package

### Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V <sub>ISOL</sub>	RMS, f = 50 Hz, t = 1 min	3.4	kV
Isolation test voltage NTC	V <sub>ISOL(NTC)</sub>	RMS, f = 50 Hz, t = 1 min	3.4	kV
Material of module baseplate			Cu	
Internal isolation		basic insulation (class 1, IEC 61140)	Al <sub>2</sub> O <sub>3</sub>	
Creepage distance	d <sub>Creep nom</sub>	terminal to baseplate, nom., (PD2, IEC 60664-1, Ed. 3.0)	> 15	mm
Creepage distance	d <sub>Creep min</sub>	terminal to baseplate, min., (PD2, IEC 60664-1, Ed. 3.0)	14.7	mm
Creepage distance	d <sub>Creep nom</sub>	terminal to terminal, nom., (PD2, IEC 60664-1, Ed. 3.0)	12.1	mm
Creepage distance	d <sub>Creep min</sub>	terminal to terminal, min., (PD2, IEC 60664-1, Ed. 3.0)	11.5	mm
Clearance	d <sub>Clear nom</sub>	terminal to baseplate, nom.	> 12.5	mm
Clearance	d <sub>Clear min</sub>	terminal to baseplate, min.	12.5	mm
Clearance	d <sub>Clear nom</sub>	terminal to terminal, nom.	10.0	mm
Clearance	d <sub>Clear min</sub>	terminal to terminal, min.	9.6	mm
Comparative tracking index	СТІ		> 200	
Relative thermal index (electrical)	RTI	housing	140	°C

### Table 2 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Тур.	Max.	
Pressure drop in cooling circuit	Δр	$\Delta V/\Delta t = 10.0 \text{ dm}^3/\text{min}, 50 \text{ ethylenglycol}, T_F = 60 °C$	$1V/\Delta t = 10.0 \text{ dm}^3/\text{min}, 50\% \text{ water } / 50\%$ thylenglycol, $T_F = 60  ^{\circ}\text{C}$		65		mbar
Maximum pressure in cooling circuit	р					3	bar
Stray inductance module	$L_{sCE}$				20		nH
Module lead resistance, terminals - chip	R <sub>CC'+EE'</sub>	T <sub>F</sub> = 25 °C, per switch	T <sub>F</sub> = 25 °C, per switch		0.8		mΩ
Storage temperature	$T_{\rm stg}$			-40		125	°C
Mounting torque for module mounting	М	- Mounting according to valid application note	M5, Screw	3		6	Nm
Terminal connection torque	М	- Mounting according to M6, Screw valid application note		3		6	Nm

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#### **EconoDUAL™3 module**

2 MOSFET, T1 / T2



## Table 2 (continued) Characteristic values

Parameter	Symbol	Note or test condition		Values		Unit
			Min.	Тур.	Max.	
Weight	G			345		g

# 2 MOSFET, T1 / T2

#### Table 3 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V <sub>DSS</sub>		T <sub>vj</sub> = 25 °C	1200	V
Continuous DC drain current	I <sub>DDC</sub>	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = 18 V	T <sub>F</sub> = 50 °C	500	А
Repetitive peak drain current	I <sub>DRM</sub>	verified by design, t <sub>p</sub> limited by T <sub>vjmax</sub>		1000	А
Gate-source voltage, max. transient voltage	V <sub>GS</sub>	D < 0.01		-10/23	V
Gate-source voltage, max. static voltage	$V_{GS}$			-7/20	V

#### Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	V <sub>GS(on)</sub>		1518	V
Off-state gate voltage	$V_{\rm GS(off)}$		-50	V

#### Table 5 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Drain-source on-resistance	R <sub>DS(on)</sub>	I <sub>D</sub> = 500 A	$V_{\rm GS} = 15  \text{V},$ $T_{\rm vj} = 25  ^{\circ}\text{C}$		1.75		mΩ
			V <sub>GS</sub> = 18 V, T <sub>vj</sub> = 25 °C		1.46	1.91	
			$V_{\rm GS}$ = 18 V, $T_{\rm vj}$ = 125 °C		2.36		
			V <sub>GS</sub> = 18 V, T <sub>vj</sub> = 175 °C		3.13		
Gate threshold voltage	V <sub>GS(th)</sub>	$I_D$ = 224 mA, $V_{DS}$ = $V_{GS}$ , $T_{vj}$ = 25 °C, (tested after 1ms pulse at $V_{GS}$ = +20 V)		3.45	4.3	5.15	V
Total gate charge	Q <sub>G</sub>	$V_{\rm DD} = 800 \text{ V}, V_{\rm GS} = -3/18 \text{ V},$	T <sub>vj</sub> = 25 °C		1.6		μC
Internal gate resistor	R <sub>Gint</sub>	T <sub>vj</sub> = 25 °C			0.9		Ω

(table continues...)

## EconoDUAL™3 module

2 MOSFET, T1 / T2



## Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Input capacitance	C <sub>ISS</sub>	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		48.4		nF
Output capacitance	C <sub>OSS</sub>	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		2.4		nF
Reverse transfer capacitance	C <sub>rss</sub>	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		0.158		nF
C <sub>OSS</sub> stored energy	Eoss	$V_{\rm DS}$ = 800 V, $V_{\rm GS}$ = -3/18 V,	T <sub>vj</sub> = 25 °C		945		μJ
Drain-source leakage current	I <sub>DSS</sub>	$V_{\rm DS}$ = 1200 V, $V_{\rm GS}$ = -3 V	T <sub>vj</sub> = 25 °C		0.32	660	μA
Gate-source leakage current	I <sub>GSS</sub>	$V_{\rm DS}$ = 0 V, $T_{\rm vj}$ = 25 °C	V <sub>GS</sub> = 20 V			400	nA
Turn-on delay time	t <sub>d on</sub>	$I_{\rm D} = 500  \text{A}, R_{\rm Gon} = 6.8  \Omega,$	T <sub>vj</sub> = 25 °C		156		ns
(inductive load)		$V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V},$ $t_{dead} = 1000 \text{ ns}$	T <sub>vj</sub> = 125 °C		172		
		dead = 1000 H3	T <sub>vj</sub> = 175 °C		182		
Rise time (inductive load)	t <sub>r</sub>	$I_{\rm D} = 500  \text{A}, R_{\rm Gon} = 6.8  \Omega,$	T <sub>vj</sub> = 25 °C		261		ns
		$V_{\rm DD}$ = 600 V, $V_{\rm GS}$ = -3/18 V, $t_{\rm dead}$ = 1000 ns	T <sub>vj</sub> = 125 °C		243		
		dead 1000113	T <sub>vj</sub> = 175 °C		238		
Turn-off delay time	$t_{\sf doff}$	$I_{\rm D} = 500 \text{ A}, R_{\rm Goff} = 3.9 \Omega,$	<i>T</i> <sub>vj</sub> = 25 °C		276		ns
(inductive load)		$V_{\rm DD} = 600 \text{ V}, V_{\rm GS} = -3/18 \text{ V}$	T <sub>vj</sub> = 125 °C		305		
			T <sub>vj</sub> = 175 °C		319		
Fall time (inductive load)	t <sub>f</sub>	$I_{\rm D} = 500  \text{A}, R_{\rm Goff} = 3.9  \Omega,$	T <sub>vj</sub> = 25 °C		74		ns
		$V_{\rm DD} = 600 \text{ V}, V_{\rm GS} = -3/18 \text{ V}$	T <sub>vj</sub> = 125 °C		76		
			T <sub>vj</sub> = 175 °C		77		
Turn-on energy loss per	E <sub>on</sub>	$I_{\rm D} = 500  \text{A}, V_{\rm DD} = 600  \text{V},$	T <sub>vj</sub> = 25 °C		40.2		mJ
pulse		$L_{\sigma} = 8 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Gon} = 6.8 \Omega, \text{ di/dt} =$	T <sub>vj</sub> = 125 °C		38.3		
		4.7 kA/ $\mu$ s (T <sub>vj</sub> = 175 °C), $t_{dead}$ = 1000 ns	T <sub>vj</sub> = 175 °C		39		
Turn-on energy loss per	E <sub>on,o</sub>	$I_{\rm D}$ = 500 A, $V_{\rm DD}$ = 600 V,	T <sub>vj</sub> = 25 °C		16.8		mJ
pulse, optimized		$L_{\sigma} = 8 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Gon.o} = 2.4 \Omega, \text{ di/dt} =$	T <sub>vj</sub> = 125 °C		17.1		
		9.3 kA/ $\mu$ s ( $T_{vj}$ = 175 °C), $t_{dead}$ = 200 ns	T <sub>vj</sub> = 175 °C		18.1		
Turn-off energy loss per	$E_{ m off}$	$I_{\rm D} = 500 \text{ A}, V_{\rm DD} = 600 \text{ V},$	T <sub>vj</sub> = 25 °C		20.4		mJ
pulse		$L_{\sigma} = 8 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Goff} = 3.9 \Omega, \text{ dv/dt} = 6.2$	T <sub>vj</sub> = 125 °C		21.6		
		$kV/\mu s (T_{vj} = 175 °C)$	T <sub>vi</sub> = 175 °C		22.2		

(table continues...)

#### **EconoDUAL™3 module**

3 Body diode (MOSFET, T1 / T2)



#### Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Тур.	Max.	
Thermal resistance, junction to cooling fluid <sup>1)</sup>	R <sub>thJF</sub>	per MOSFET, $\Delta V/\Delta t = 10.0 \text{ dm}^3/$ min, cooling fluid = 50% water / 50% ethylenglycol, T <sub>F</sub> = 60 °C		0.12		K/W
Temperature under switching conditions	T <sub>vj op</sub>		-40		175	°C

<sup>1)</sup> Typical R<sub>thJF</sub> value using the heat sink described in AN-2022-05

#### Note:

The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

Tvj op > 150°C is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.

## 3 Body diode (MOSFET, T1 / T2)

#### Table 6 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit	
DC body diode forward	I <sub>SD</sub>	$T_{\rm vi} = 175 ^{\circ}\text{C}, V_{\rm GS} = -3 ^{\circ}\text{V}$	T <sub>F</sub> = 25 °C	295	A
current		,			

#### Table 7 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур. Мах.	Max.	
Forward voltage	V <sub>SD</sub>	$I_{SD} = 500 \text{ A}, V_{GS} = -3 \text{ V}$	T <sub>vj</sub> = 25 °C		4.14	5.2	V
			T <sub>vj</sub> = 125 °C		3.88		1
			T <sub>vj</sub> = 175 °C		3.78		
Peak reverse recovery current	I <sub>rrm</sub>	$I_{SD} = 500 \text{ A, di}_{s}/\text{dt} =$	T <sub>vj</sub> = 25 °C		76		Α
		4.7 kA/ $\mu$ s, $V_{DD}$ = 600 V, $V_{GS}$ =-3 V, $t_{dead}$ = 1000 ns	T <sub>vj</sub> = 125 °C		114		
			T <sub>vj</sub> = 175 °C		148		
Recovered charge	Q <sub>rr</sub>	$I_{SD} = 500 \text{ A, di}_{s}/\text{dt} =$	T <sub>vj</sub> = 25 °C		3.7		μC
		4.7 kA/ $\mu$ s, $V_{DD}$ = 600 V, $V_{GS}$ =-3 V, $t_{dead}$ = 1000 ns	T <sub>vj</sub> = 125 °C		4.9		
		V <sub>GS</sub> 3 V, t <sub>dead</sub> - 1000 IIS	T <sub>vj</sub> = 175 °C		7		
Reverse recovery energy	E <sub>rec</sub>	$I_{SD} = 500 \text{ A, di}_{s}/\text{dt} =$	T <sub>vj</sub> = 25 °C		0.12		mJ
		4.7 kA/ $\mu$ s ( $T_{vj} = 175$ °C),	T <sub>vj</sub> = 125 °C		0.37		
	$V_{\rm DD}$ = 600 V, $V_{\rm GS}$ =-3 V, $t_{\rm dead}$ = 1000 ns	, 00 ,	T <sub>vj</sub> = 175 °C		0.67		

(table continues...)

#### **EconoDUAL™3 module**

4 NTC-Thermistor



## Table 7 (continued) Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Тур.	Max.	
Reverse recovery energy,	E <sub>rec,o</sub>	$I_{SD} = 500 \text{ A, di}_{s}/\text{dt} =$	T <sub>vj</sub> = 25 °C		1.3		mJ
optimized		9.3 kA/ $\mu$ s ( $T_{vj} = 175$ °C),	T <sub>vj</sub> = 125 °C		3.8		
		$I_{SD}$ = 500 A, di <sub>s</sub> /dt = 9.3 kA/µs (T <sub>vj</sub> = 175 °C), $V_{DD}$ = 600 V, $V_{GS}$ = -3 V, $t_{dead}$ = 200 ns	T <sub>vj</sub> = 175 °C		5.3		

## 4 NTC-Thermistor

#### Table 8 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Тур.	Max.	
Rated resistance	R <sub>25</sub>	T <sub>NTC</sub> = 25 °C		5		kΩ
Deviation of R <sub>100</sub>	∆R/R	$T_{\rm NTC} = 100 {}^{\circ}{\rm C}$ , $R_{100} = 493 \Omega$	-5		5	%
Power dissipation	P <sub>25</sub>	T <sub>NTC</sub> = 25 °C			20	mW
B-value	B <sub>25/50</sub>	$R_2 = R_{25} \exp[B_{25/50}(1/T_2-1/(298,15 \text{ K}))]$		3375		K
B-value	B <sub>25/80</sub>	$R_2 = R_{25} \exp[B_{25/80}(1/T_2-1/(298,15 \text{ K}))]$		3411		К
B-value	B <sub>25/100</sub>	$R_2 = R_{25} \exp[B_{25/100}(1/T_2-1/(298,15 \text{ K}))]$		3433		K

**Note**: For an analytical description of the NTC characteristics please refer to AN2009-10, chapter 4.

5 Characteristics diagrams

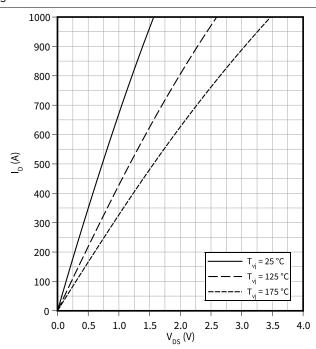


## **5** Characteristics diagrams

#### Output characteristic (typical), MOSFET, T1 / T2

 $I_D = f(V_{DS})$ 

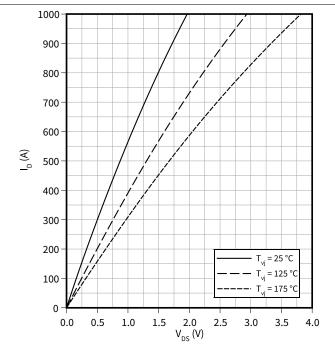
 $V_{GS} = 18 V$ 



### Output characteristic (typical), MOSFET, T1 / T2

 $I_D = f(V_{DS})$ 

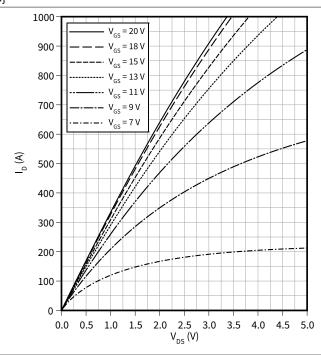
 $V_{GS} = 15 V$ 



### Output characteristic field (typical), MOSFET, T1 / T2

 $I_D = f(V_{DS})$ 

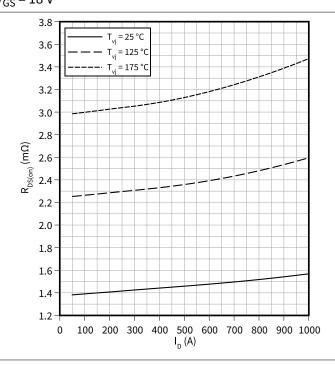
 $T_{vj} = 175 \,^{\circ}\text{C}$ 



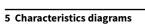
## Drain source on-resistance (typical), MOSFET, T1 / T2

 $R_{DS(on)} = f(I_D)$ 

V<sub>GS</sub> = 18 V



#### EconoDUAL™3 module

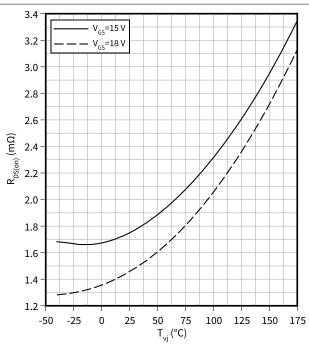




## Drain source on-resistance (typical), MOSFET, T1 / T2

$$R_{DS(on)} = f(T_{vj})$$

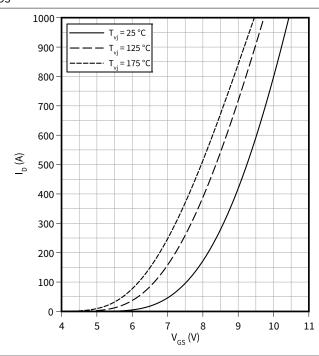




## Transfer characteristic (typical), MOSFET, T1 / T2

$$I_D = f(V_{GS})$$

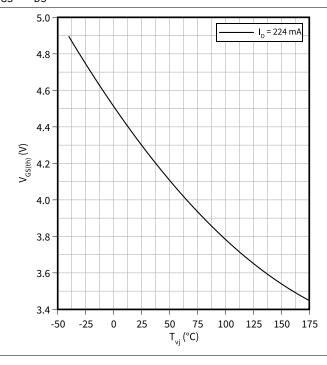
$$V_{DS} = 20 V$$



# Gate-source threshold voltage (typical), MOSFET, T1 $\!\!\!/$ T2

$$V_{GS(th)} = f(T_{vj})$$

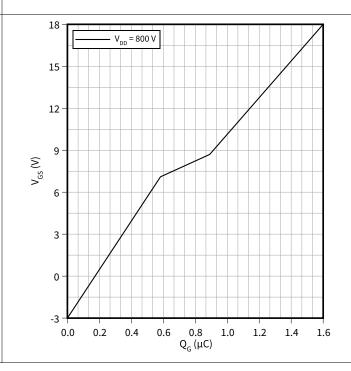
$$V_{GS} = V_{DS}$$



### Gate charge characteristic (typical), MOSFET, T1 / T2

$$V_{GS} = f(Q_G)$$

$$I_D = 500 A$$
,  $T_{vi} = 25 °C$ 



#### EconoDUAL™3 module

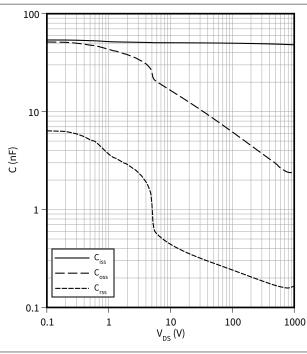




## Capacity characteristic (typical), MOSFET, T1 / T2

 $C = f(V_{DS})$ 

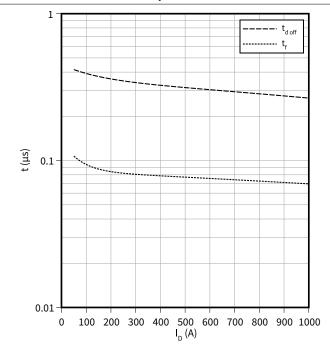
 $T_{vj} = 25 \, ^{\circ}\text{C}, \, V_{GS} = 0 \, \text{V}, \, f = 100 \, \text{kHz}$ 



## Switching times (typical), MOSFET, T1 / T2

 $t = f(I_D)$ 

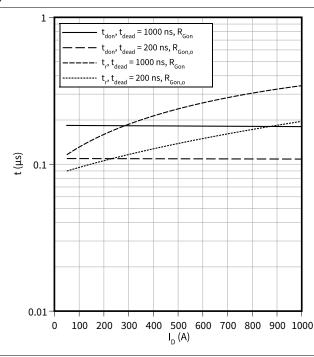
 $R_{Goff}$  = 3.9  $\Omega$ ,  $V_{DD}$  = 600 V,  $T_{vj}$  = 175 °C,  $V_{GS}$  = -3/18 V



## Switching times (typical), MOSFET, T1 $\!\!\!/$ T2

 $t = f(I_D)$ 

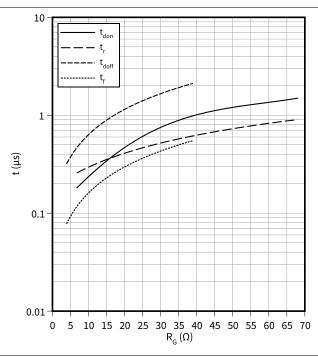
 $V_{DD}$  = 600 V,  $R_{Gon}$  = 6.8  $\Omega,\,R_{Gon,o}$  = 2.4  $\Omega,\,T_{vj}$  = 175 °C,  $V_{GS}$  = -3/18 V



### Switching times (typical), MOSFET, T1 / T2

 $t = f(R_G)$ 

 $V_{DD}$  = 600 V,  $t_{dead}$  = 1000 ns,  $I_D$  = 500 A,  $T_{vj}$  = 175 °C,  $V_{GS}$  = -3/18 V



#### EconoDUAL™3 module

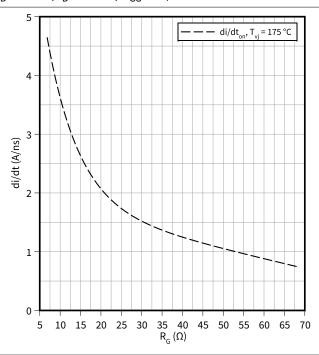
5 Characteristics diagrams



### Current slope (typical), MOSFET, T1 / T2

 $di/dt = f(R_G)$ 

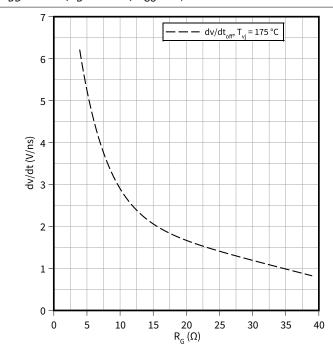
$$V_{DD} = 600 \text{ V}, I_D = 500 \text{ A}, V_{GS} = -3/18 \text{ V}$$



#### Voltage slope (typical), MOSFET, T1 / T2

 $dv/dt = f(R_G)$ 

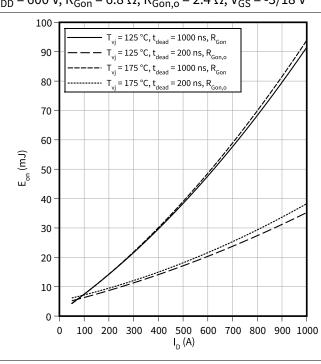
$$V_{DD} = 600 \text{ V}, I_D = 500 \text{ A}, V_{GS} = -3/18 \text{ V}$$



## Switching losses (typical), MOSFET, T1 $\!\!/$ T2

 $E_{on} = f(I_D)$ 

$$V_{DD} = 600 \text{ V}, R_{Gon} = 6.8 \Omega, R_{Gon,o} = 2.4 \Omega, V_{GS} = -3/18 \text{ V}$$

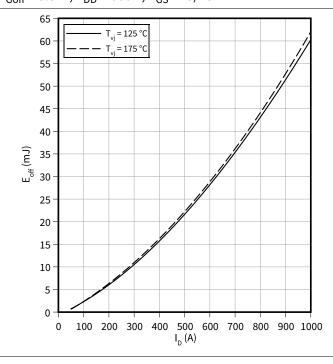


## Switching losses (typical), MOSFET, T1 / T2

 $E_{off} = f(I_D)$ 

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$$R_{Goff} = 3.9 \Omega$$
,  $V_{DD} = 600 V$ ,  $V_{GS} = -3/18 V$ 



#### **EconoDUAL™3 module**

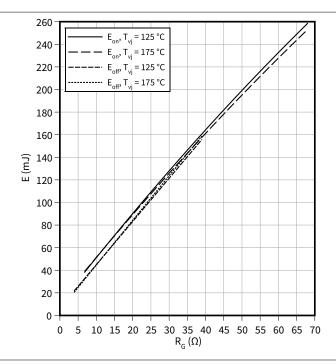




## Switching losses (typical), MOSFET, T1 $\!\!/$ T2

 $E = f(R_G)$ 

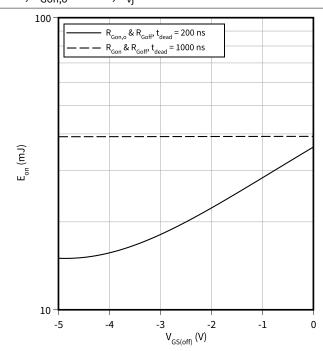
 $V_{DD}$  = 600 V,  $t_{dead}$  = 1000 ns,  $I_{D}$  = 500 A,  $V_{GS}$  = -3/18 V



#### Switching losses (typical), MOSFET, T1 / T2

 $E_{on} = f(V_{GS(off)})$ 

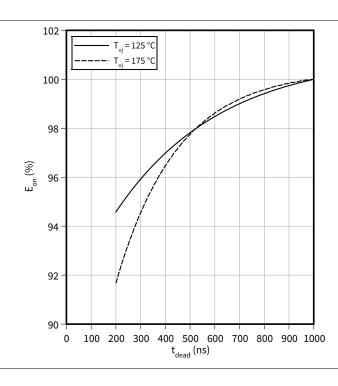
 $R_{Goff} = 3.9 \Omega$ ,  $V_{DD} = 600 V$ ,  $R_{Gon} = 6.8 \Omega$ ,  $V_{GS(on)} = 18 V$ ,  $I_{D} = 500 A$ ,  $R_{Gon,o} = 2.4 \Omega$ ,  $T_{vj} = 175 °C$ 



## Switching losses (typical), MOSFET, T1 / T2

 $E_{on} = f(t_{dead})$ 

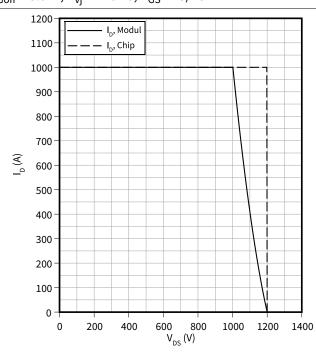
 $R_{Gon} = 6.8 \Omega$ ,  $I_D = 500 A$ ,  $V_{DD} = 600 V$ ,  $V_{GS} = -3/18 V$ 



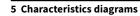
# Reverse bias safe operating area (RBSOA), MOSFET, T1 / T2

 $I_D = f(V_{DS})$ 

 $R_{Goff} = 3.9 \Omega$ ,  $T_{vi} = 175 \,^{\circ}$ C,  $V_{GS} = -3/18 \,^{\circ}$ V



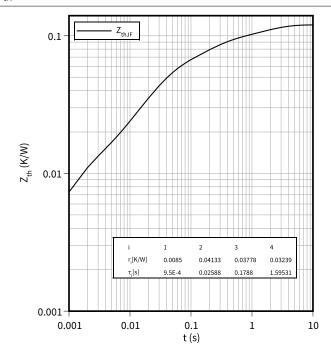
#### EconoDUAL™3 module





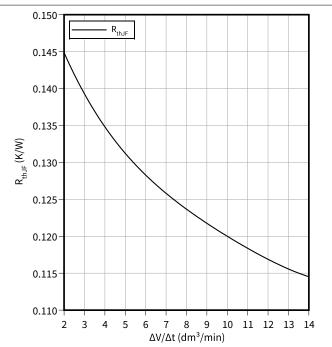
## Transient thermal impedance, MOSFET, T1 / T2 $\,$

#### $Z_{th} = f(t)$



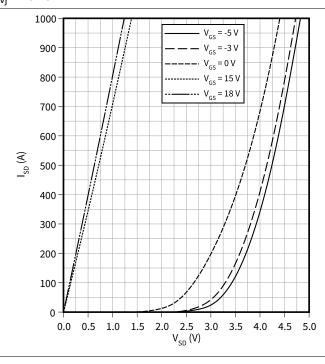
### Thermal impedance, MOSFET, T1 / T2

$$R_{thJF} = f(\Delta V/\Delta t)$$



# Forward characteristic body diode (typical), MOSFET, T1 / T2 $\,$

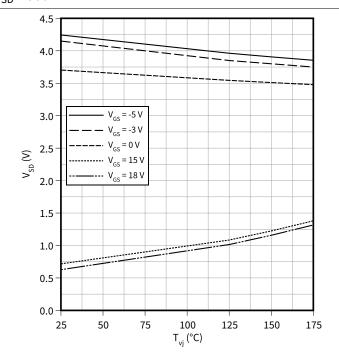
 $I_{SD} = f(V_{SD})$ 



# Forward voltage of body diode (typical), MOSFET, T1 /

$$V_{SD} = f(T_{vi})$$

$$I_{SD} = 500 A$$



#### **EconoDUAL™3 module**

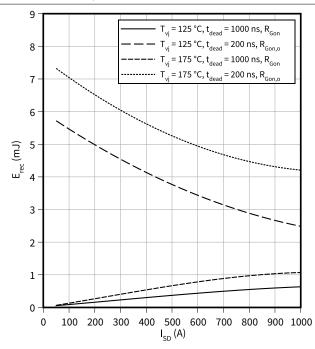




## Switching losses body diode (typical), MOSFET, T1 / T2

 $E_{rec} = f(I_{SD})$ 

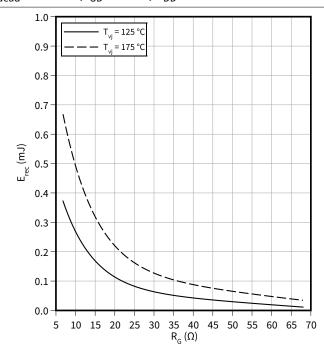
 $R_{Gon} = 6.8 \Omega$ ,  $R_{Gon,o} = 2.4 \Omega$ ,  $V_{DD} = 600 V$ 



#### Switching losses body diode (typical), MOSFET, T1 / T2

 $E_{rec} = f(R_G)$ 

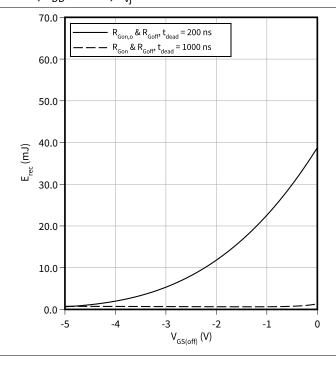
 $t_{dead} = 1000 \text{ ns}, I_{SD} = 500 \text{ A}, V_{DD} = 600 \text{ V}$ 



## Switching losses body diode (typical), MOSFET, T1 / T2

 $E_{rec} = f(V_{GS(off)})$ 

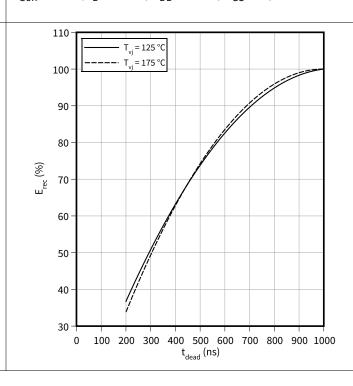
 $R_{Goff}$  = 3.9  $\Omega$ ,  $R_{Gon}$  = 6.8  $\Omega$ ,  $V_{GS(on)}$  = 18 V,  $I_{SD}$  = 500 A,  $R_{Gon,o}$  = 2.4  $\Omega$ ,  $V_{DD}$  = 600 V,  $T_{vi}$  = 175 °C



#### Switching losses body diode (typical), MOSFET, T1 / T2

 $E_{rec} = f(t_{dead})$ 

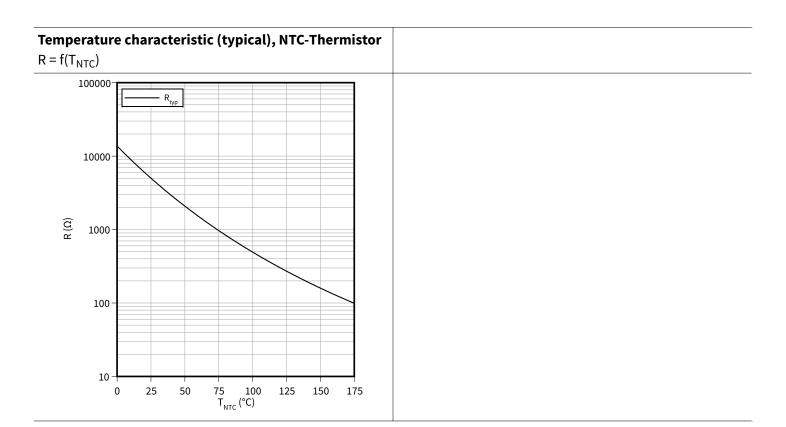
 $R_{Gon} = 6.8 \Omega$ ,  $I_D = 500 A$ ,  $V_{DD} = 600 V$ ,  $V_{GS} = -3/18 V$ 



#### **EconoDUAL™3 module**



5 Characteristics diagrams



**EconoDUAL™3 module** 



6 Circuit diagram

#### **Circuit diagram** 6

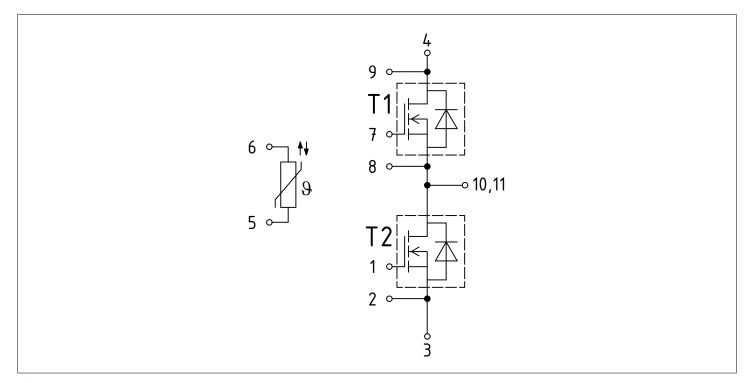


Figure 1

7 Package outlines



# 7 Package outlines

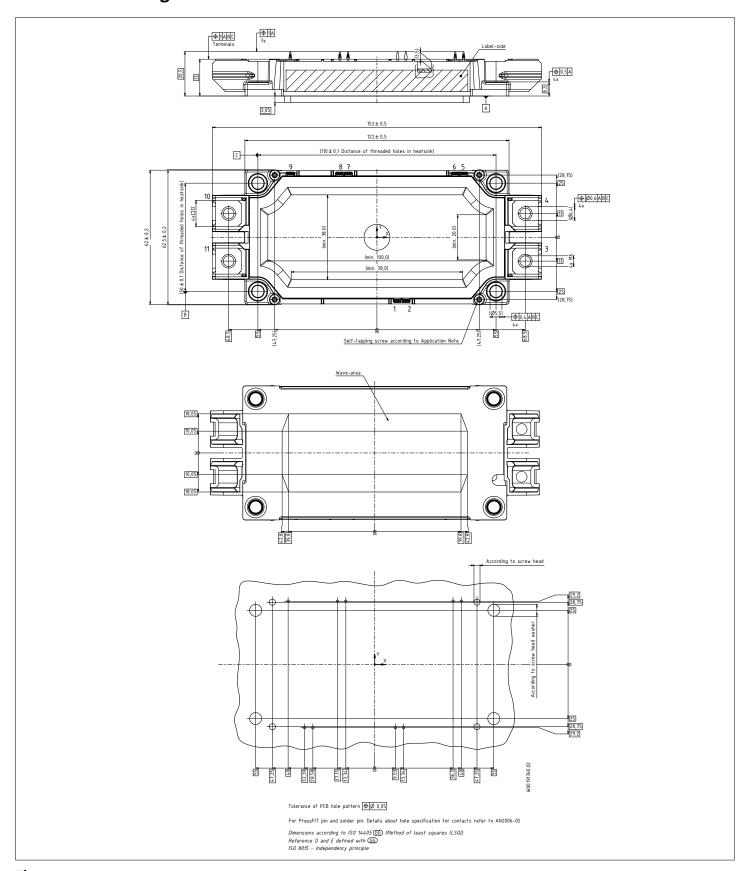


Figure 2

## EconoDUAL™3 module

8 Module label code



## 8 Module label code

	Data Matrix		Barra da Cada 120		
Code format	Data Matrix		Barcode Code128		
Encoding	ASCII text		Code Set A		
Symbol size	16x16		23 digits		
Standard	IEC24720 and IEC16022		IEC8859-1		
Code content	Content	Digit		Example	
	Module serial number	1-5		71549	
	Module material number 6 - 11			142846	
	Production order number	12 - 19		55054991	
	Date code (production year)	20 – 21		15	
	Date code (production week)	22 – 23		30	
Example	100 Page 100				

Figure 3

## **EconoDUAL™3 module**



Revision history

# **Revision history**

Document revision	Date of release	Description of changes
0.10	2024-12-02	Preliminary datasheet
1.00	2025-03-06	Final datasheet

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